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Kind regards,

Team Nexperia



PSMN3R0-60ES

N-channel 60 V 3.0 mΩ standard level MOSFET in I2PAK.

3 June 2014

Product data sheet

1. General description

Standard level N-channel MOSFET in a I2PAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

2. Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

3. Applications

- DC-to-DC converters
- Load switching
- Motor control
- Server power supplies

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | | Min | Typ | Max | Unit |
|--------------------------------|----------------------------------|---|-----|-----|-----|-----|------|
| V_{DS} | drain-source voltage | $T_j \geq 25 \text{ }^\circ\text{C}; T_j \leq 175 \text{ }^\circ\text{C}$ | | - | - | 60 | V |
| I_D | drain current | $T_{mb} = 25 \text{ }^\circ\text{C}; V_{GS} = 10 \text{ V}$; Fig. 2 | [1] | - | - | 100 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25 \text{ }^\circ\text{C}$; Fig. 1 | | - | - | 306 | W |
| Static characteristics | | | | | | | |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ }^\circ\text{C}$; Fig. 11 ; Fig. 12 | | - | 2.4 | 3 | mΩ |
| Dynamic characteristics | | | | | | | |
| Q_{GD} | gate-drain charge | $V_{GS} = 10 \text{ V}; I_D = 80 \text{ A}; V_{DS} = 12 \text{ V}$; Fig. 13 ; Fig. 14 | | - | 28 | - | nC |

[1] Continuous current is limited by package.

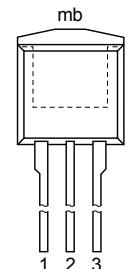
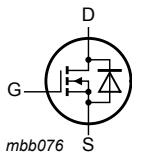


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5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|---|---|
| 1 | G | gate | | |
| 2 | D | drain | | |
| 3 | S | source | | |
| mb | D | mounting base; connected to drain |  I2PAK (SOT226) |  |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|--------------|---------|--|---------|
| | Name | Description | Version |
| PSMN3R0-60ES | I2PAK | plastic single-ended package (I2PAK); TO-262 | SOT226 |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|--------------|--------------|
| PSMN3R0-60ES | PSMN3R0-60ES |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|-------------------------|---|-----|------|------|
| V_{DS} | drain-source voltage | $T_j \geq 25^\circ\text{C}$; $T_j \leq 175^\circ\text{C}$ | - | 60 | V |
| V_{DGR} | drain-gate voltage | $T_j \geq 25^\circ\text{C}$; $T_j \leq 175^\circ\text{C}$; $R_{GS} = 20\text{ k}\Omega$ | - | 60 | V |
| V_{GS} | gate-source voltage | | -20 | 20 | V |
| P_{tot} | total power dissipation | $T_{mb} = 25^\circ\text{C}$; Fig. 1 | - | 306 | W |
| I_D | drain current | $V_{GS} = 10\text{ V}$; $T_{mb} = 100^\circ\text{C}$; Fig. 2 | - | 83.4 | A |
| | | $V_{GS} = 10\text{ V}$; $T_{mb} = 25^\circ\text{C}$; Fig. 2 | [1] | 100 | A |
| I_{DM} | peak drain current | pulsed; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25^\circ\text{C}$; Fig. 3 | - | 824 | A |
| T_{stg} | storage temperature | | -55 | 175 | °C |

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|-----------------------------|--|--|-----|-----|-----|------|
| T _j | junction temperature | | | -55 | 175 | °C |
| Source-drain diode | | | | | | |
| I _S | source current | T _{mb} = 25 °C | [1] | - | 100 | A |
| I _{SM} | peak source current | pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C | | - | 824 | A |
| Avalanche ruggedness | | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V _{GS} = 10 V; T _{j(init)} = 25 °C; I _D = 100 A; V _{sup} ≤ 60 V; R _{GS} = 50 Ω; unclamped | | - | 800 | mJ |

[1] Continuous current is limited by package.

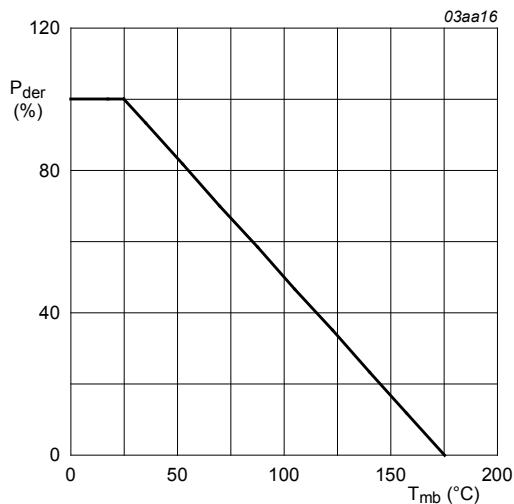


Fig. 1. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot}(25°C)} \times 100 \%$$

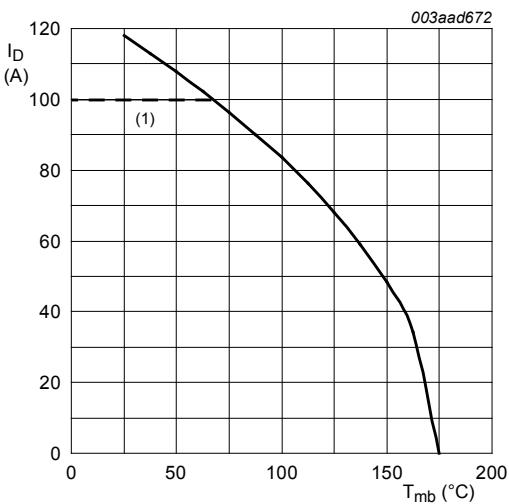


Fig. 2. Continuous drain current as a function of mounting base temperature.

V_{GS} ≥ 10 V; (1) Capped at 100 A due to package

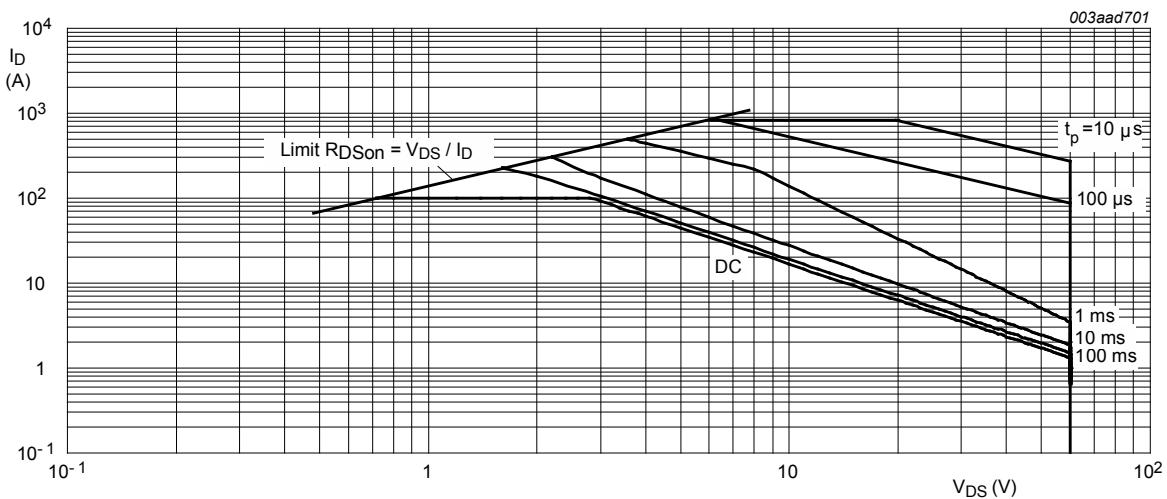


Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

$T_{mb} = 25^\circ\text{C}$; I_{DM} is a single pulse; Capped at 100 A due to package

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|---|------------------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Fig. 4 | - | 0.3 | 0.49 | K/W |

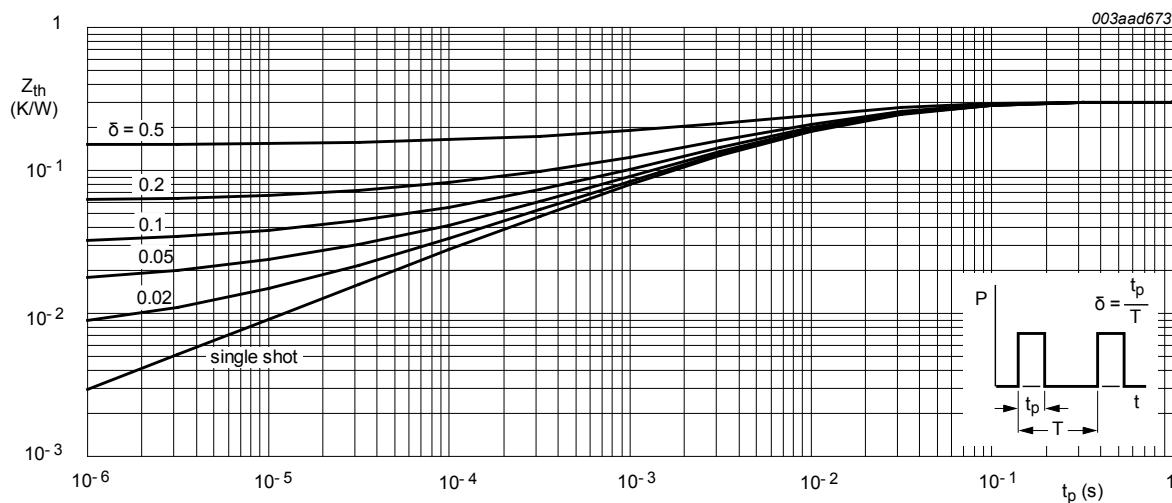


Fig. 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

| Symbol | Parameter | Conditions | | Min | Typ | Max | Unit |
|--------------------------------|----------------------------------|--|--|------|------|-----|-----------|
| Static characteristics | | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55^\circ C$ | | 54 | - | - | V |
| | | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25^\circ C$ | | 60 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25^\circ C$ Fig. 8 ; Fig. 9 | | 2 | 3 | 4 | V |
| V_{GSth} | gate-source threshold voltage | $I_D = 1 mA; V_{DS} = V_{GS}; T_j = 175^\circ C$ Fig. 9 | | 1 | - | - | V |
| | | $I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55^\circ C$ Fig. 9 | | - | - | 4.6 | V |
| I_{DSS} | drain leakage current | $V_{DS} = 60 V; V_{GS} = 0 V; T_j = 25^\circ C$ | | - | 0.05 | 10 | μA |
| | | $V_{DS} = 60 V; V_{GS} = 0 V; T_j = 175^\circ C$ | | - | - | 500 | μA |
| I_{GSS} | gate leakage current | $V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25^\circ C$ | | - | 2 | 100 | nA |
| | | $V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25^\circ C$ | | - | 2 | 100 | nA |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 10 V; I_D = 25 A; T_j = 175^\circ C$ Fig. 10 | | - | - | 7.2 | $m\Omega$ |
| | | $V_{GS} = 10 V; I_D = 25 A; T_j = 25^\circ C$ Fig. 11 ; Fig. 12 | | - | 2.4 | 3 | $m\Omega$ |
| R_G | gate resistance | $f = 1 MHz$ | | 0.55 | 1.1 | 2.2 | Ω |
| Dynamic characteristics | | | | | | | |
| $Q_{G(tot)}$ | total gate charge | $I_D = 80 A; V_{DS} = 12 V; V_{GS} = 10 V$ Fig. 13 ; Fig. 14 | | - | 130 | - | nC |
| Q_{GS} | gate-source charge | $I_D = 80 A; V_{DS} = 12 V; V_{GS} = 10 V$ Fig. 14 ; Fig. 13 | | - | 43 | - | nC |
| Q_{GD} | gate-drain charge | $I_D = 80 A; V_{DS} = 12 V; V_{GS} = 10 V$ Fig. 13 ; Fig. 14 | | - | 28 | - | nC |
| C_{iss} | input capacitance | $V_{DS} = 30 V; V_{GS} = 0 V; f = 1 MHz$ $T_j = 25^\circ C$; Fig. 15 ; Fig. 16 | | - | 8079 | - | pF |
| C_{oss} | output capacitance | $V_{DS} = 30 V; V_{GS} = 0 V; f = 1 MHz$ $T_j = 25^\circ C$; Fig. 15 | | - | 971 | - | pF |
| C_{rss} | reverse transfer capacitance | $V_{DS} = 30 V; V_{GS} = 0 V; f = 1 MHz$ $T_j = 25^\circ C$; Fig. 15 ; Fig. 16 | | - | 492 | - | pF |
| $t_{d(on)}$ | turn-on delay time | $V_{DS} = 30 V; R_L = 0.5 \Omega; V_{GS} = 10 V$ $R_{G(ext)} = 1.5 \Omega$ | | - | 31 | - | ns |
| t_r | rise time | | | - | 26 | - | ns |
| $t_{d(off)}$ | turn-off delay time | | | - | 77 | - | ns |
| t_f | fall time | | | - | 22 | - | ns |

| Symbol | Parameter | Conditions | | Min | Typ | Max | Unit |
|---------------------------|-----------------------|---|--|-----|------|-----|------|
| Source-drain diode | | | | | | | |
| V_{SD} | source-drain voltage | $I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$; Fig. 17 | | - | 0.88 | 1.2 | V |
| t_{rr} | reverse recovery time | $I_S = 25 \text{ A}$; $dI_S/dt = -100 \text{ A}/\mu\text{s}$; $V_{GS} = 0 \text{ V}$ | | - | 54 | - | ns |
| Q_r | recovered charge | $V_{DS} = 30 \text{ V}$ | | - | 97 | - | nC |

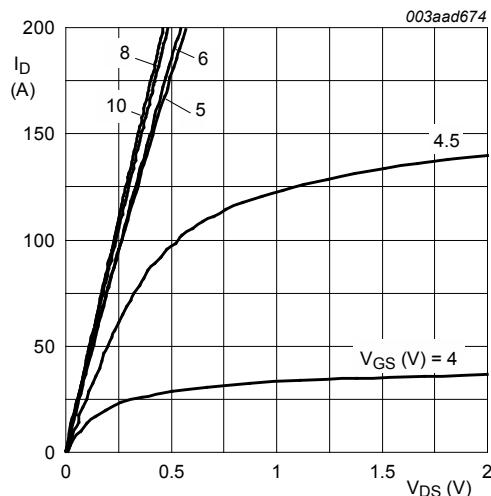


Fig. 5. Output characteristics: drain current as a function of drain-source voltage; typical values

$T_j = 25 \text{ }^\circ\text{C}$

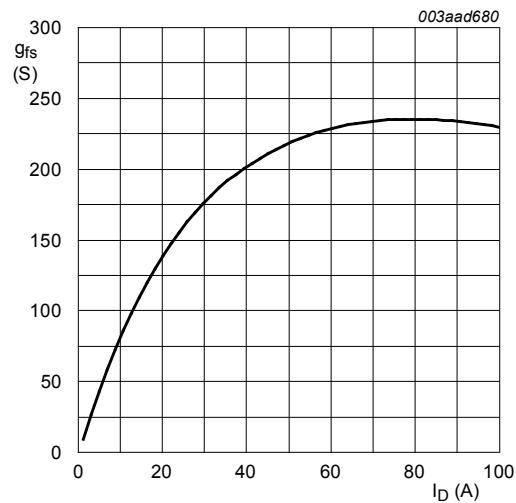


Fig. 6. Forward transconductance as a function of drain current; typical values

$T_j = 25 \text{ }^\circ\text{C}; V_{DS} = 30\text{V}$

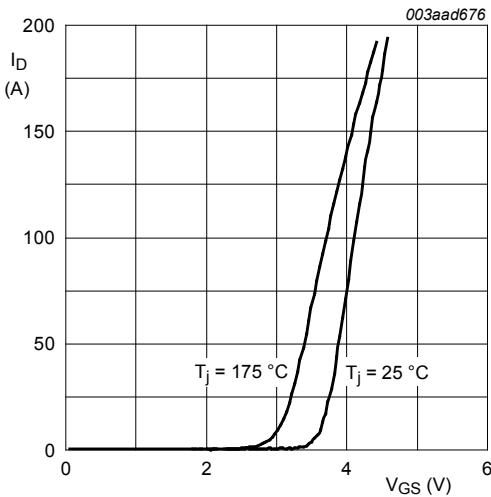


Fig. 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

$V_{DS} > I_D \times R_{DSon}$

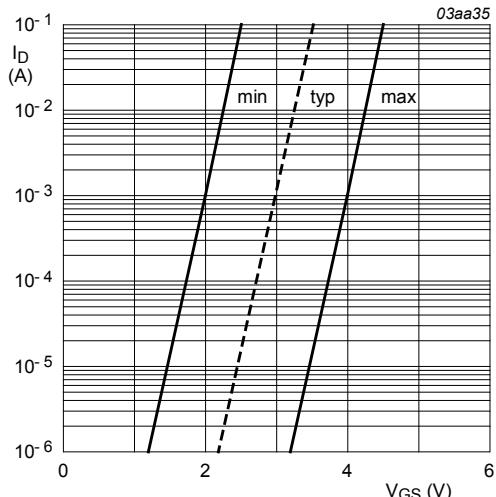


Fig. 8. Sub-threshold drain current as a function of gate-source voltage

$T_j = 25 \text{ }^\circ\text{C}; V_{DS} = 5\text{V}$

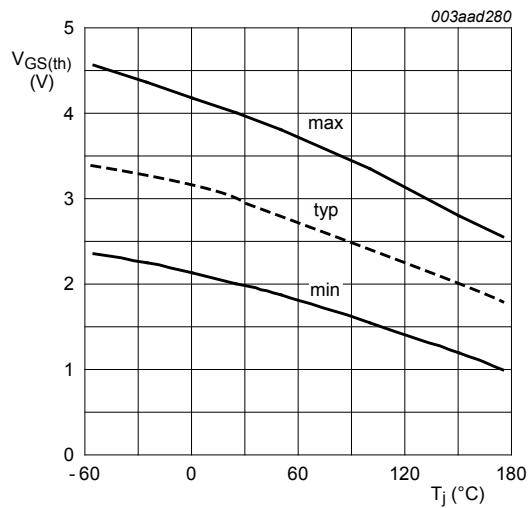


Fig. 9. Gate-source threshold voltage as a function of junction temperature

$$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$$

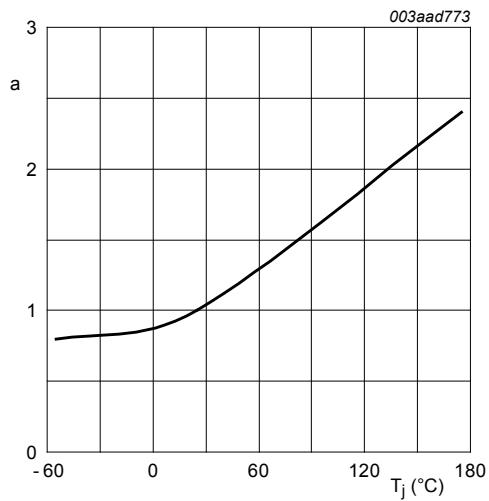


Fig. 10. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon}(25 \text{ } ^\circ\text{C})}$$

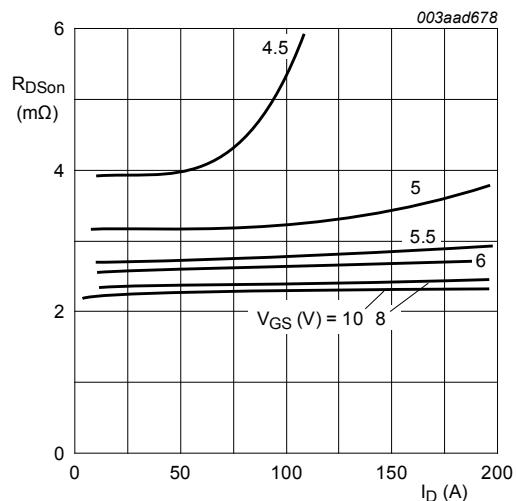


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values

$$T_j = 25 \text{ } ^\circ\text{C}$$

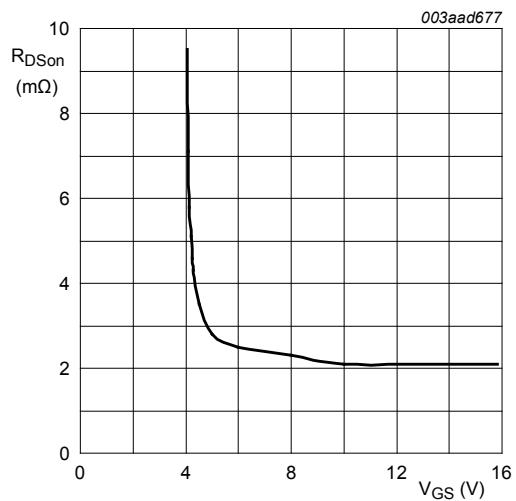


Fig. 12. Drain-source on-state resistance as a function of gate-source voltage; typical values

$$T_j = 25 \text{ } ^\circ\text{C}; I_D = 25 \text{ A}$$

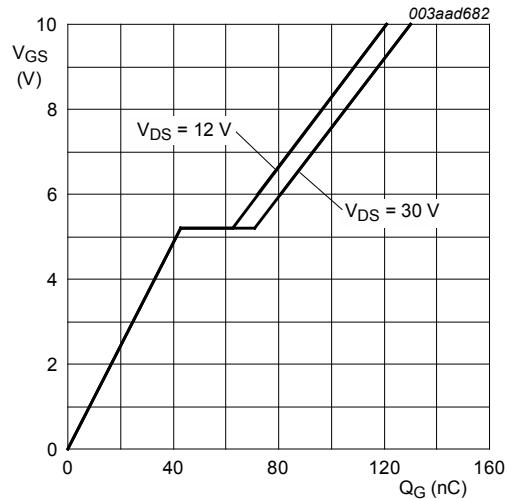


Fig. 13. Gate-source voltage as a function of gate charge; typical values

$T_j = 25\text{ }^\circ\text{C}$; $I_D = 25\text{ A}$

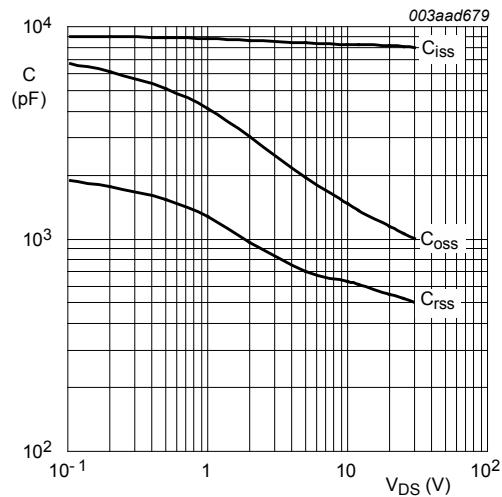


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$V_{GS} = 0\text{ V}$; $f = 1\text{ MHz}$

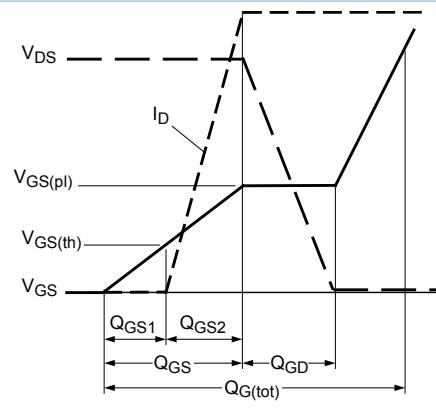


Fig. 14. Gate charge waveform definitions

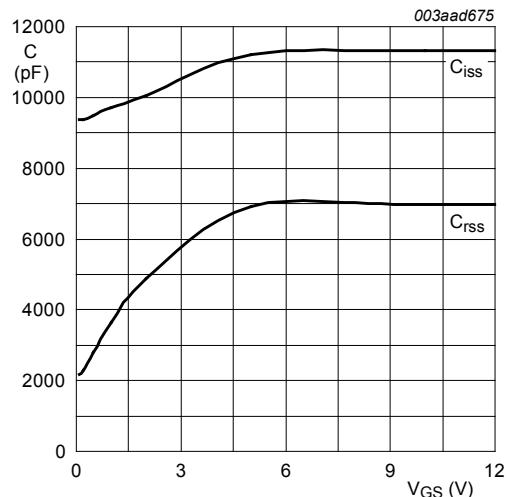


Fig. 16. Input and reverse transfer capacitances as a function of gate-source voltage, typical values

$V_{DS} = 0\text{ V}$; $f = 1\text{ MHz}$

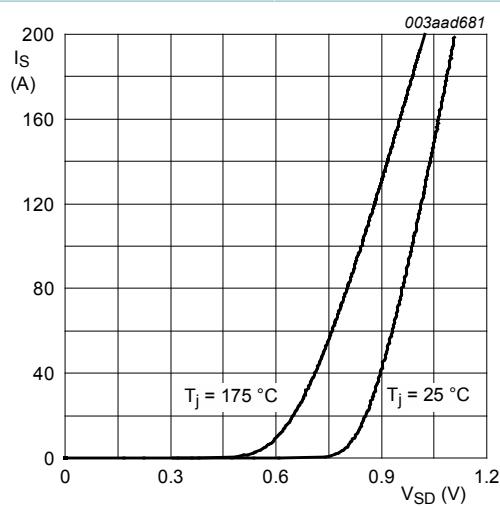


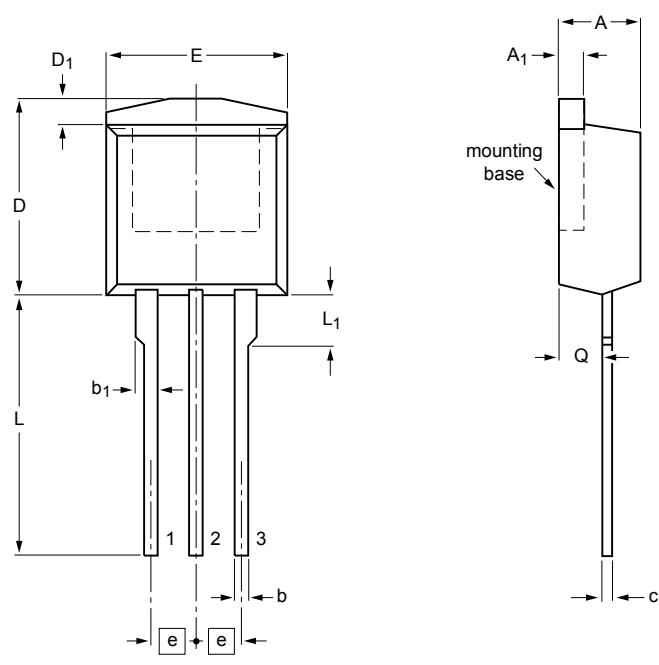
Fig. 17. Source current as a function of source-drain voltage; typical values

$V_{GS} = 0 \text{ V}$

11. Package outline

Plastic single-ended package (I2PAK); low-profile 3-lead TO-262

SOT226



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ | b | b ₁ | c | D _{max} | D ₁ | E | e | L | L ₁ | Q |
|------|------------|----------------|--------------|----------------|------------|------------------|----------------|-------------|------|--------------|----------------|------------|
| mm | 4.5 4.1 | 1.40 1.27 | 0.85 0.60 | 1.3 1.0 | 0.7 0.4 | 11 | 1.6 1.2 | 10.3 9.7 | 2.54 | 15.0 13.5 | 3.30 2.79 | 2.6 2.2 |

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|--------|-------|--|---------------------|--------------------|
| | IEC | JEDEC | JEITA | | | |
| SOT226 | | TO-262 | | | | -06-02-14-09-08-25 |

Fig. 18. Package outline I2PAK (SOT226)

12. Legal information

12.1 Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------|--------------------|---|
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13. Contents

| | | |
|------|-------------------------------|----|
| 1 | General description | 1 |
| 2 | Features and benefits | 1 |
| 3 | Applications | 1 |
| 4 | Quick reference data | 1 |
| 5 | Pinning information | 2 |
| 6 | Ordering information | 2 |
| 7 | Marking | 2 |
| 8 | Limiting values | 2 |
| 9 | Thermal characteristics | 4 |
| 10 | Characteristics | 5 |
| 11 | Package outline | 10 |
| 12 | Legal information | 11 |
| 12.1 | Data sheet status | 11 |
| 12.2 | Definitions | 11 |
| 12.3 | Disclaimers | 11 |
| 12.4 | Trademarks | 12 |

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